



|                      | <i>Name</i>  | <i>Function</i>     | <i>Date</i> | <i>Signature</i> |
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|              |             |             |                      |
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## 1 INTRODUCTION

This document contains a summary of the suggested methods and requirements set forth by the IEC/IEEE 62209-1528 and FCC KDB865664 D01 standards for liquid permittivity measurements and the measurements that were performed to verify that the product complies with the fore mentioned standards.

## 2 DEVICE UNDER TEST

| Device Under Test              |                          |
|--------------------------------|--------------------------|
| Device Type                    | LIMESAR DIELECTRIC PROBE |
| Manufacturer                   | MVG                      |
| Model                          | SCLMP                    |
| Serial Number                  | SN 06/22 OCPG 88         |
| Product Condition (new / used) | New                      |

## 3 PRODUCT DESCRIPTION

### 3.1 GENERAL INFORMATION

MVG's Dielectric Probes are built in accordance to the IEC/IEEE 62209-1528 and FCC KDB865664 D01 standards. The product is designed for use with the LIMESAR test bench only.



**Figure 1 – MVG LIMESAR Dielectric Probe**

## 4 MEASUREMENT METHOD

The IEC/IEEE 62209-1528 and FCC KDB865664 D01 standards outline techniques for dielectric property measurements. The LIMESAR test bench employs one of the methods outlined in the standards, using a contact probe or open-ended coaxial transmission-line probe and vector network analyzer. The standards recommend the measurement of two reference materials that have well established and stable dielectric properties to validate the system, one for the calibration and one for checking the calibration. The LIMESAR test bench uses De-ionized water as the reference for the calibration and either DMS or Methanol as the reference for checking the calibration. The following measurements were performed to verify that the product complies with the fore mentioned standards.

### 4.1 LIQUID PERMITTIVITY MEASUREMENTS

The permittivity of a liquid with well established dielectric properties was measured and the measurement results compared to the values provided in the fore mentioned standards.

## 5 MEASUREMENT UNCERTAINTY

All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of  $k=2$ , traceable to the Internationally Accepted Guides to Measurement Uncertainty.

### 5.1 DIELECTRIC PERMITTIVITY MEASUREMENT

The following uncertainties apply to the Dielectric Permittivity measurement:

| Uncertainty analysis of Permittivity Measurement         |                          |                          |         |    |                             |
|----------------------------------------------------------|--------------------------|--------------------------|---------|----|-----------------------------|
| ERROR SOURCES                                            | Uncertainty value (+/-%) | Probability Distribution | Divisor | ci | Standard Uncertainty (+/-%) |
| Expanded uncertainty (confidence level of 95%, $k = 2$ ) |                          |                          |         |    | 10 %                        |

| Uncertainty analysis of Conductivity Measurement         |                          |                          |         |    |                             |
|----------------------------------------------------------|--------------------------|--------------------------|---------|----|-----------------------------|
| ERROR SOURCES                                            | Uncertainty value (+/-%) | Probability Distribution | Divisor | ci | Standard Uncertainty (+/-%) |
| Expanded uncertainty (confidence level of 95%, $k = 2$ ) |                          |                          |         |    | 8.2%                        |

## 6 CALIBRATION MEASUREMENT RESULTS

### Measurement Condition

|                    |             |
|--------------------|-------------|
| Software           | LIMESAR     |
| Liquid Temperature | 20 +/- 1 °C |
| Lab Temperature    | 20 +/- 1 °C |
| Lab Humidity       | 30-70 %     |